

**Notice of References Cited**

Application/Control No.

10/644,245

Applicant(s)/Patent Under  
Reexamination  
HATWAR ET AL.

Examiner

Dawn Garrett

Art Unit

1774

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0170496	09-2003	Hieda et al.	428/690
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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